



Low-Voltage, CMOS Analog Multiplexers/Switches

MAX4581/MAX4582/MAX4583

General Description

The MAX4581/MAX4582/MAX4583 are low-voltage, CMOS analog ICs configured as an 8-channel multiplexer (MAX4581), two 4-channel multiplexers (MAX4582), and three single-pole/double-throw (SPDT) switches (MAX4583).

These CMOS devices can operate continuously with $\pm 2V$ to $\pm 6V$ dual power supplies or a $+2V$ to $+12V$ single supply. Each switch can handle Rail-to-Rail[®] analog signals. The off-leakage current is only 1nA at $+25^{\circ}C$ or 5nA at $+85^{\circ}C$.

All digital inputs have 0.8V to 2.4V logic thresholds, ensuring TTL/CMOS-logic compatibility when using a single $+5V$ or dual $\pm 5V$ supplies.

Applications

- Battery-Operated Equipment
- Audio and Video Signal Routing
- Low-Voltage Data-Acquisition Systems
- Communications Circuits
- Automotive

Features

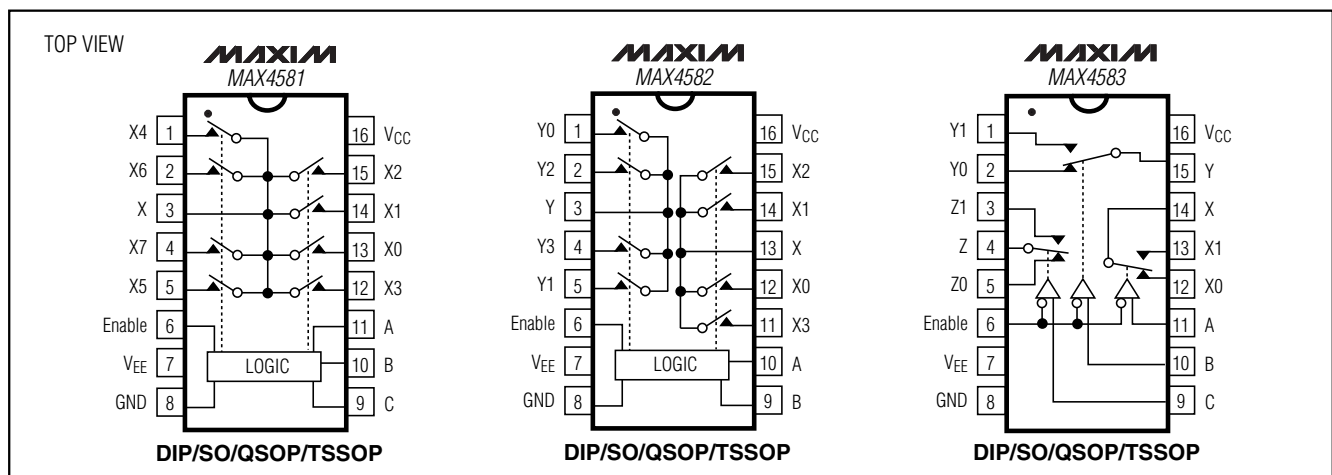
- ◆ Pin Compatible with Industry-Standard 74HC4051/74HC4052/74HC4053 and MAX4051/MAX4052/MAX4053
- ◆ Offered in Automotive Temperature Range ($-40^{\circ}C$ to $+125^{\circ}C$)
- ◆ Guaranteed On-Resistance:
80 Ω with $\pm 5V$ Supplies
150 Ω with Single $+5V$ Supply
- ◆ Guaranteed On-Resistance Match Between Channels
- ◆ Guaranteed Low Off-Leakage Current:
1nA at $+25^{\circ}C$
- ◆ Guaranteed Low On-Leakage Current:
1nA at $+25^{\circ}C$
- ◆ $+2V$ to $+12V$ Single-Supply Operation
 $\pm 2V$ to $\pm 6V$ Dual-Supply Operation
- ◆ TTL/CMOS-Logic Compatible
- ◆ Low Distortion: $< 0.02\%$ (600 Ω)
- ◆ Low Crosstalk: $< -96dB$ (50 Ω , MAX4582)
- ◆ High Off-Isolation: $< -74dB$ (50 Ω)

Ordering Information

PART	TEMP. RANGE	PIN-PACKAGE
MAX4581CPE	0 $^{\circ}C$ to $+70^{\circ}C$	16 Plastic DIP
MAX4581CSE	0 $^{\circ}C$ to $+70^{\circ}C$	16 Narrow SO
MAX4581CUE	0 $^{\circ}C$ to $+70^{\circ}C$	16 TSSOP

Ordering Information continued at end of data sheet.

Pin Configurations/Functional Diagrams



Rail-to-Rail is a registered trademark of Nippon Motorola, Ltd.



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ABSOLUTE MAXIMUM RATINGS

Voltages Referenced to V_{EE}

V_{CC}.....-0.3V to 13V

Voltage into Any Terminal (Note 1) ... (V_{EE} - 0.3V) to (V_{CC} + 0.3V)

Continuous Current into Any Terminal.....±20mA

Peak Current, X₋, Y₋, Z₋

(pulsed at 1ms, 10% duty cycle)±40mA

ESD per Method 3015.7>2000V

Continuous Power Dissipation (T_A = +70°C)

Plastic DIP (derate 10.53mW/°C above +70°C).....842mW

Narrow SO (derate 8.70mW/°C above +70°C).....696mW

QSOP (derate 8.3mW/°C above +70°C)667mW

TSSOP (derate 6.7mW/°C above +70°C).....457mW

QFN (derate 18.5mW/°C above +70°C).....1481mW

Operating Temperature Ranges

MAX458_C_0°C to +70°C

MAX458_E_-40°C to +85°C

MAX458_A_-40°C to +125°C

Storage Temperature Range-65°C to +150°C

Lead Temperature (soldering, 10s)+300°C

Note 1: Voltages exceeding V_{CC} or V_{EE} on any signal terminal are clamped by internal diodes. Limit forward-diode current to maximum current rating.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS—Dual Supplies

(V_{CC} = 4.5V to 5.5V, V_{EE} = -4.5V to -5.5V, V_H = 2.4V, V_L = 0.8V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted. Typical values are at T_A = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	TEMP	MIN	TYP (Note 2)	MAX	UNITS
ANALOG SWITCH							
Analog-Signal Range	V _X , V _Y , V _Z		C, E, A	V _{EE}		V _{CC}	V
Switch On-Resistance	R _{ON}	V _{CC} = 4.5V; V _{EE} = -4.5V; I _X , I _Y , I _Z = 1mA; V _X , V _Y , V _Z = 3.5V	+25°C		50	80	Ω
			C, E, A			100	
Switch On-Resistance Match Between Channels (Note 3)	ΔR _{ON}	V _{CC} = 4.5V; V _{EE} = -4.5V; I _X , I _Y , I _Z = 1mA; V _X , V _Y , V _Z = 3.5V	+25°C		1	4	Ω
			C, E, A			6	
Switch On-Resistance Flatness (Note 4)	R _{FLAT(ON)}	V _{CC} = 5V; V _{EE} = -5V; I _X , I _Y , I _Z = 1mA; V _X , V _Y , V _Z = 3V, 0V, -3V	+25°C		4	10	Ω
			C, E, A			12	
X ₋ , Y ₋ , Z ₋ Off Leakage (Note 5)	I _{X(OFF)} , I _{Y(OFF)} , I _{Z(OFF)}	V _{CC} = 5.5V; V _{EE} = -5.5V; V _{X-} , V _{Y-} , V _{Z-} = ±4.5V; V _X , V _Y , V _Z = ∓4.5V	+25°C	-1		1	nA
			C, E, A	-10		10	
X, Y, Z Off Leakage (Note 5)	I _{X(OFF)} , I _{Y(OFF)} , I _{Z(OFF)}	V _{CC} = 5.5V; V _{EE} = -5.5V; V _{X-} , V _{Y-} , V _{Z-} = ±4.5V; V _X , V _Y , V _Z = ∓4.5V	MAX4581	+25°C	-2	2	nA
			MAX4582 MAX4583	C, E, A	-100	100	
				+25°C	-1	1	
X, Y, Z On Leakage (Note 5)	I _{X(ON)} , I _{Y(ON)} , I _{Z(ON)}	V _{CC} = 5.5V; V _{EE} = -5.5V; V _X , V _Y , V _Z = ±4.5V	MAX4581	+25°C	-2	2	nA
			MAX4582 MAX4583	C, E, A	-100	100	
				+25°C	-1	1	
MAX4582 MAX4583			C, E, A	+25°C	-50	50	
DIGITAL I/O							
Logic Input Logic Threshold High	V _{AH} , V _{BH} , V _{CH}		C, E, A		1.5	2.4	V
Logic Input Logic Threshold Low	V _{AL} , V _{BL} , V _{CL}		C, E, A	0.8	1.5		V

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ELECTRICAL CHARACTERISTICS—Dual Supplies (continued)

($V_{CC} = 4.5V$ to $5.5V$, $V_{EE} = -4.5V$ to $-5.5V$, $V_H = 2.4V$, $V_L = 0.8V$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$.)

PARAMETER	SYMBOL	CONDITIONS	TEMP	MIN	TYP (Note 2)	MAX	UNITS
Input Current High	I_{AH} , I_{BH} , I_{CH}	$V_A, V_B, V_C = 2.4V$	C, E, A	-1		1	μA
Input Current Low	I_{AL} , I_{BL} , I_{CL}	$V_A, V_B, V_C = 0.8V$	C, E, A	-1		1	μA
SWITCH DYNAMIC CHARACTERISTICS							
Inhibit Turn-On Time	$t_{(ON)}$	$V_{X-}, V_{Y-}, V_{Z-} = 3V$; $R_L = 300\Omega$; $C_L = 35pF$; Figure 3	$T_A = +25^\circ C$ C, E, A		100	200	ns
Inhibit Turn-Off Time	$t_{(OFF)}$	$V_{X-}, V_{Y-}, V_{Z-} = 3V$; $R_L = 300\Omega$; $C_L = 35pF$; Figure 3	$T_A = +25^\circ C$ C, E, A		40	100	ns
Address Transition Time	t_{TRANS}	$V_{X-}, V_{Y-}, V_{Z-} = \pm 3V$; $R_L = 300\Omega$; $C_L = 35pF$; Figure 2	$T_A = +25^\circ C$ C, E, A		90	200	ns
Break-Before-Make Time	t_{BBM}	$V_{X-}, V_{Y-}, V_{Z-} = 3V$; $R_L = 300\Omega$; $C_L = 35pF$; Figure 4	$T_A = +25^\circ C$	4	20		ns
Charge Injection (Note 6)	Q	$C = 1nF$, $R_S = 0\Omega$, $V_S = 0V$	$T_A = +25^\circ C$		0.5	5	pC
Input Off Capacitance	$C_{X(OFF)}$, $C_{Y(OFF)}$, $C_{Z(OFF)}$	$V_{X-}, V_{Y-}, V_{Z-} = 0V$; $f = 1MHz$; Figure 7	$T_A = +25^\circ C$		4		pF
Output Off Capacitance	$C_{X(OFF)}$, $C_{Y(OFF)}$, $C_{Z(OFF)}$	$V_{X-}, V_{Y-}, V_{Z-} = 0V$; $f = 1MHz$; Figure 7	$T_A = +25^\circ C$	MAX4581	18		pF
				MAX4582	10		
				MAX4583	6		
Output On Capacitance	$C_{X(ON)}$, $C_{Y(ON)}$, $C_{Z(ON)}$	$V_{X-}, V_{Y-}, V_{Z-} = 0V$; $f = 1MHz$; Figure 7	$T_A = +25^\circ C$	MAX4581	25		pF
				MAX4582	17		
				MAX4583	12.5		
Off Isolation	V_{ISO}	$R_L = 50\Omega$, $f = 1MHz$, Figure 6	$T_A = +25^\circ C$		-73		dB
Channel-to-Channel Crosstalk	V_{CT}	$R_L = 50\Omega$, $f = 1MHz$, Figure 6	MAX4582	$T_A = +25^\circ C$	-96		pF
			MAX4583	$T_A = +25^\circ C$	-73		
Total Harmonic Distortion	THD	$R_L = 600\Omega$, $5Vp-p$, $f = 20Hz$ to $20kHz$	$T_A = +25^\circ C$		0.02		%
POWER SUPPLY							
Power-Supply Range	V_{CC} , V_{EE}		C, E, A	± 2		± 6	V
Power-Supply Current	I_{CC} , I_{EE}	$V_{CC} = 5.5V$, $V_{EE} = -5.5V$, $V_A, V_B, V_C, V_{Enable} = V+$ or 0	$T_A = +25^\circ C$	-1		1	μA
			C, E, A	-10		10	

Note 2: The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

Note 3: $\Delta R_{ON} = R_{ON(MAX)} - R_{ON(MIN)}$.

Note 4: Flatness is defined as the difference between the maximum and minimum value of on-resistance as measured over the specified analog signal ranges; i.e., $V_{X-}, V_{Y-}, V_{Z-} = 3V$ to 0 and 0 to $-3V$.

Note 5: Leakage parameters are 100% tested at maximum-rated hot operating temperature, and guaranteed by correlation at $T_A = +25^\circ C$.

Note 6: Guaranteed by design, not production tested.

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ELECTRICAL CHARACTERISTICS—Single +5V Supply

(V_{CC} = 4.5V to 5.5V, V_{EE} = 0V, V_H = 2.4V, V_L = 0.8V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted. Typical values are at T_A = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	TEMP	MIN	TYP (Note 2)	MAX	UNITS
ANALOG SWITCH							
Analog-Signal Range	V _{X-} , V _{Y-} , V _{Z-} , V _X , V _Y , V _Z		C, E, A	V _{EE}		V _{CC}	V
Switch On-Resistance	R _{ON}	V _{CC} = 4.5V; I _X , I _Y , I _Z = 1mA; V _X , V _Y , V _Z = 3.5V	T _A = +25°C C, E, A		90	150 200	Ω
Switch On-Resistance Match Between Channels (Note 3)	ΔR _{ON}	V _{CC} = 4.5V; I _X , I _Y , I _Z = 1mA; V _X , V _Y , V _Z = 3.5V	T _A = +25°C C, E, A		2	8 10	Ω
X ₋ , Y ₋ , Z ₋ Off Leakage (Note 5)	I _{X(OFF)} , I _{Y(OFF)} , I _{Z(OFF)}	V _{CC} = 5.5V; V _{X-} , V _{Y-} , V _{Z-} = 1V, 4.5V; V _X , V _Y , V _Z = 4.5V, 1V	T _A = +25°C C, E, A	-1		1 10	nA
X, Y, Z Off Leakage (Note 5)	I _{X(OFF)} , I _{Y(OFF)} , I _{Z(OFF)}	V _{CC} = 5.5V; V _{X-} , V _{Y-} , V _{Z-} = 1V, 4.5V; V _X , V _Y , V _Z = 4.5V, 1V	MAX4581	T _A = +25°C	-2	2	nA
				C, E, A	-100	100	
			MAX4582 MAX4583	T _A = +25°C C, E, A	-1 -50	1 50	
X, Y, Z On Leakage (Note 5)	I _{X(ON)} , I _{Y(ON)} , I _{Z(ON)}	V _{CC} = 5.5V; V _X , V _Y , V _Z = 4.5V, 1V	MAX4581	T _A = +25°C	-2	2	nA
				C, E, A	-100	100	
			MAX4582 MAX4583	T _A = +25°C C, E, A	-1 -50	1 50	
DIGITAL I/O							
Logic Input Logic Threshold High	V _{AH} , V _{BH} , V _{CH} , V _{EnableH}		C, E, A		1.5	2.4	V
Logic Input Logic Threshold Low	V _{AL} , V _{BL} , V _{CL} , V _{EnableL}		C, E, A	0.8	1.5		V
Input Current High	I _{AH} , I _{BH} , I _{CH} , I _{EnableH}	V _{AL} , V _{BL} , V _{CL} , V _{EnableL} = 2.4V	C, E, A	-1		1	μA
Input Current Low	I _{AL} , I _{BL} , I _{CL} , I _{EnableL}	V _{AL} , V _{BL} , V _{CL} , V _{EnableL} = 0.8V	C, E, A	-1		1	μA
SWITCH DYNAMIC CHARACTERISTICS							
Charge Injection (Note 6)	Q	C = 1nF, R _S = 0Ω, V _S = 2.5V	T _A = +25°C		0.8	5	pC
Enable Turn-On Time	t _(ON)	V _{X-} , V _{Y-} , V _{Z-} = 3V, R _L = 300Ω, C _L = 35pF, Figure 3	T _A = +25°C		100	200	ns
				C, E, A		250	
Enable Turn-Off Time	t _(OFF)	V _{X-} , V _{Y-} , V _{Z-} = 3V, R _L = 300Ω, C _L = 35pF, Figure 3	T _A = +25°C		40	100	ns
				C, E, A		150	
Address Transition Time	t _{TRANS}	V _{X-} , V _{Y-} , V _{Z-} = 3V/0V, R _L = 300Ω, C _L = 35pF, Figure 2	T _A = +25°C		80	200	ns
				C, E, A		250	
Break-Before-Make Time	t _{BBM}	V _{X-} , V _{Y-} , V _{Z-} = 3V, R _L = 300Ω, C _L = 35pF, Figure 4	T _A = +25°C	10	30		ns

Note 2: The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

Note 3: ΔR_{ON} = R_{ON(MAX)} - R_{ON(MIN)}.

Note 4: Flatness is defined as the difference between the maximum and minimum value of on-resistance as measured over the specified analog signal ranges; i.e., V_{X-}, V_{Y-}, V_{Z-} = 3V to 0 and 0 to -3V.

Note 5: Leakage parameters are 100% tested at maximum-rated hot operating temperature, and guaranteed by correlation at T_A = +25°C.

Note 6: Guaranteed by design, not production tested.

Low-Voltage, CMOS Analog Multiplexers/Switches

MAX4581/MAX4582/MAX4583

ELECTRICAL CHARACTERISTICS—Single +3V Supply

(V_{CC} = 2.7V to 3.6V, V_{EE} = 0V, V_H = 2.0V, V_L = 0.5V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted. Typical values are at T_A = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	TEMP	MIN	TYP (Note 2)	MAX	UNITS
POWER SUPPLY							
Power-Supply Range	V _{CC} , V _{EE}		C, E, A	2		12	V
Power-Supply Current	I _{CC} , I _{EE}	V _{CC} = 3.6V; V _A , V _B , V _C , V _{Enable} = V+ or 0	T _A = +25°C	-1		1	μA
			C, E, A	-10		10	
ANALOG SWITCH							
Analog-Signal Range	V _{X-} , V _{Y-} , V _{Z-} , V _X , V _Y , V _Z		C, E, A	V _{EE}		V _{CC}	V
Switch On-Resistance	R _{ON}	V _{CC} = 2.7V; I _X , I _Y , I _Z = 0.1mA; V _X , V _Y , V _Z = 1.5V	T _A = +25°C		190	450	Ω
			C, E, A			550	
X ₋ , Y ₋ , Z ₋ Off Leakage (Note 5)	I _{X(OFF)} , I _{Y(OFF)} , I _{Z(OFF)}	V _{CC} = 3.6V; V _{X-} , V _{Y-} , V _{Z-} = 1V, 3V; V _X , V _Y , V _Z = 3V, 1V	T _A = +25°C	-1		1	nA
			C, E, A	-10		10	
X, Y, Z Off Leakage (Note 6)	I _{X(OFF)} , I _{Y(OFF)} , I _{Z(OFF)}	V _{CC} = 3.6V; V _{X-} , V _{Y-} , V _{Z-} = 1V, 3.0V; V _X , V _Y , V _Z = 3.0V, 1V	MAX4581	T _A = +25°C	-2	2	nA
			MAX4582 MAX4583	C, E, A	-100	100	
				C, E, A	-50	50	
X, Y, Z On Leakage (Note 6)	I _{X(ON)} , I _{Y(ON)} , I _{Z(ON)}	V _{CC} = 3.6V; V _X , V _Y , V _Z = 3.0V, 1V	MAX4581	T _A = +25°C	-2	2	nA
			MAX4582 MAX4583	C, E, A	-100	100	
				C, E, A	-50	50	
DIGITAL I/O							
Logic Input Logic Threshold High	V _{AH} , V _{BH} , V _{CH} , V _{EnableH}		C, E, A		1.0	2.0	V
Logic Input Logic Threshold Low	V _{AL} , V _{BL} , V _{CL} , V _{EnableL}		C, E, A	0.5	1.0		V
Input Current High	I _{AH} , I _{BH} , I _{CH} , I _{EnableH}	V _A , V _B , V _C = V _{Enable} = 2.0V	C, E, A	-1		1	μA
Input Current Low	I _{AL} , I _{BL} , I _{CL} , I _{EnableL}	V _A , V _B , V _C = V _{Enable} = 0.5V	C, E, A	-1		1	μA
SWITCH DYNAMIC CHARACTERISTICS (Note 6)							
Enable Turn-On Time	t _(ON)	V _{X-} , V _{Y-} , V _{Z-} = 1.5V; R _L = 300Ω; C _L = 35pF; Figure 3	T _A = +25°C		170	300	ns
			C, E, A			400	
Enable Turn-Off Time	t _(OFF)	V _{X-} , V _{Y-} , V _{Z-} = 1.5V; R _L = 300Ω; C _L = 35pF; Figure 3	T _A = +25°C		50	200	ns
			C, E, A			300	
Address Transition Time	t _{TRANS}	V _{X-} , V _{Y-} , V _{Z-} = 1.5V/0V; R _L = 300Ω; C _L = 35pF; Figure 2	T _A = +25°C		130	300	ns
			C, E, A			400	
Break-Before-Make Time	t _{BBM}	V _{X-} , V _{Y-} , V _{Z-} = 1.5V; R _L = 300Ω; C _L = 35pF	T _A = +25°C	15	40		ns
POWER SUPPLY							
Power-Supply Current	I _{CC} , I _{EE}	V _{CC} = 3.6V, V _A , V _B , V _C , V _{Enable} = V+ or 0	T _A = +25°C	-1		1	μA
			C, E, A	-10		10	

Note 2: The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

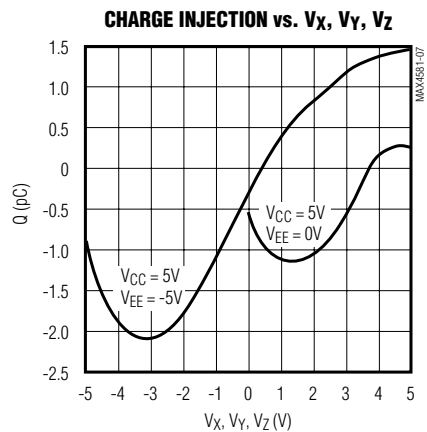
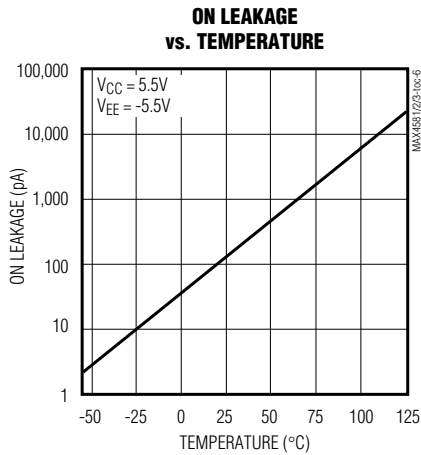
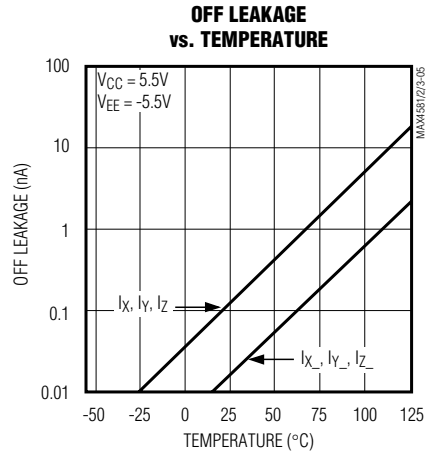
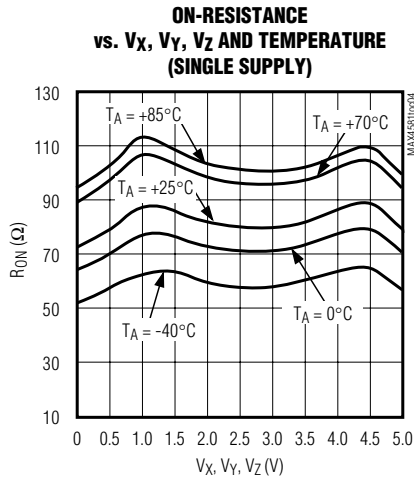
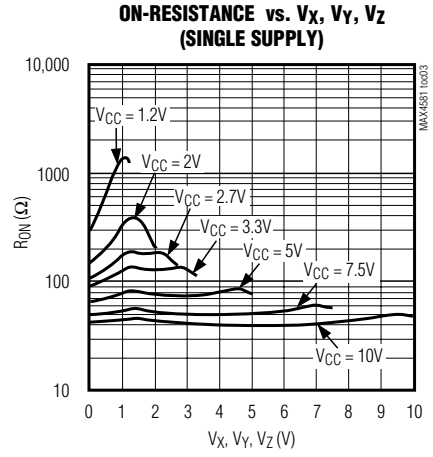
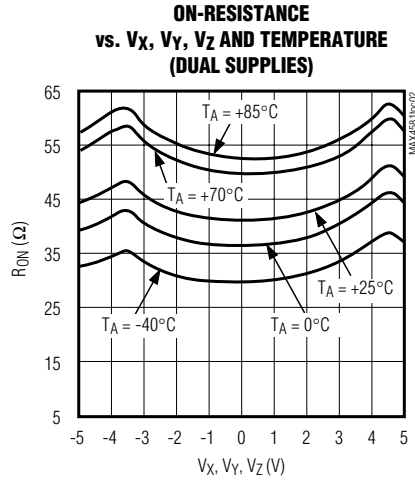
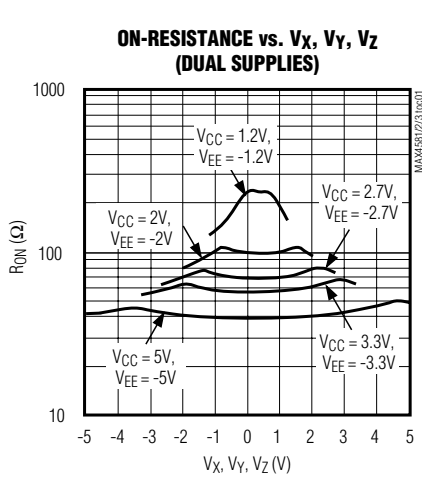
Note 5: Leakage parameters are 100% tested at maximum-rated hot operating temperature, and guaranteed by correlation at T_A = +25°C.

Note 6: Guaranteed by design, not production tested.

Low-Voltage, CMOS Analog Multiplexers/Switches

Typical Operating Characteristics

($V_{CC} = 5V$, $V_{EE} = -5V$, $GND = 0V$, $T_A = +25^\circ C$, unless otherwise noted.)

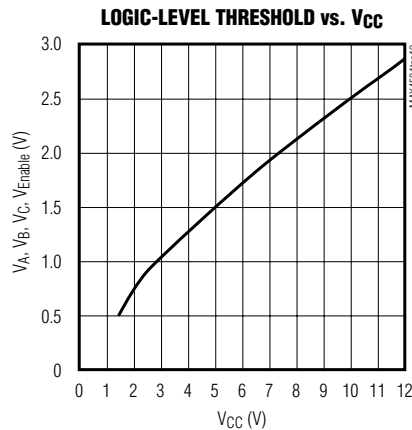
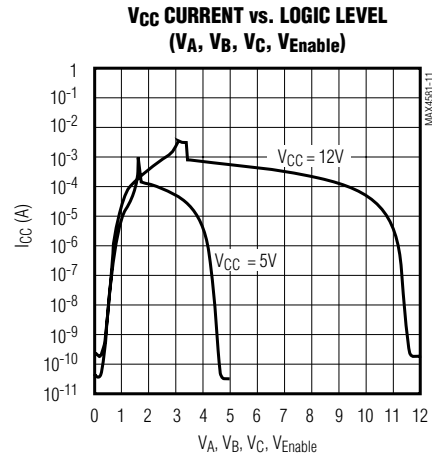
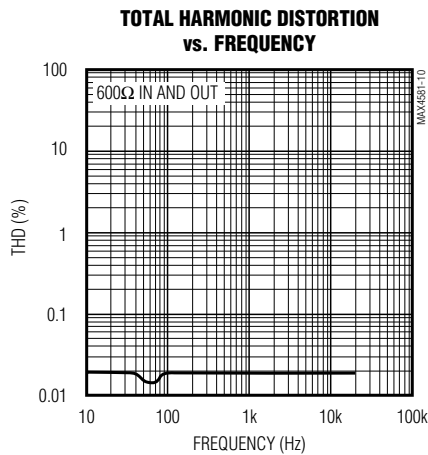
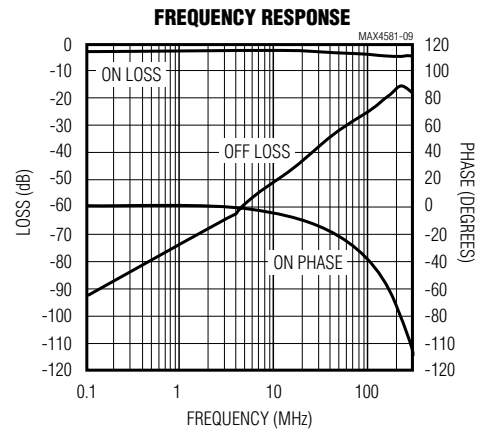
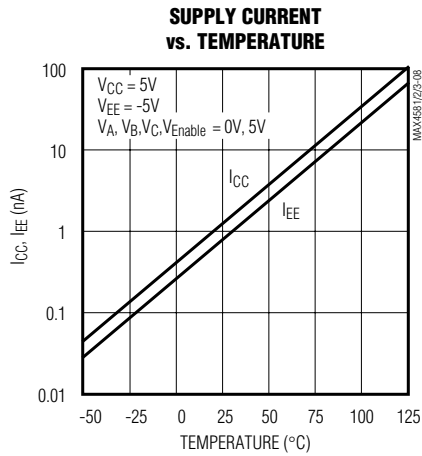


Low-Voltage, CMOS Analog Multiplexers/Switches

Typical Operating Characteristics (continued)

($V_{CC} = 5V$, $V_{EE} = -5V$, $GND = 0V$, $T_A = +25^\circ C$, unless otherwise noted.)

MAX4581/MAX4582/MAX4583



Low-Voltage, CMOS Analog Multiplexers/Switches

Pin Description

PIN						NAME	FUNCTION
MAX4581		MAX4582		MAX4583			
DIP, SO, TSSOP	QFN	DIP, SO, TSSOP	QFN	DIP, SO, TSSOP	QFN		
13, 14, 15, 12, 1, 5, 2, 4	11, 12, 13, 10, 15, 3, 16, 2	—	—	—	—	X0–X7	Analog Switch Inputs 0–7
3	1	13	11	14	12	X	Analog Switch “X” Output
—	—	12, 14, 15, 11	10, 12, 13, 9	—	—	X0, X1, X2, X3	Analog Switch “X” Inputs 0–3
—	—	1, 5, 2, 4	15, 3, 16, 2	—	—	Y0, Y1, Y2, Y3	Analog Switch “Y” Inputs 0–3
—	—	3	1	15	13	Y	Analog Switch “Y” Output
—	—	—	—	13	11	X1	Analog Switch “X” Normally Open Input
—	—	—	—	12	10	X0	Analog Switch “X” Normally Closed Input
—	—	—	—	1	15	Y1	Analog Switch “Y” Normally Open Input
—	—	—	—	2	16	Y0	Analog Switch “Y” Normally Open Input
—	—	—	—	3	1	Z1	Analog Switch “Z” Normally Open Input
—	—	—	—	5	3	Z0	Analog Switch “Z” Normally Open Input
—	—	—	—	4	2	Z	Analog Switch “Z” Output
16	14	16	14	16	14	V _{CC}	Positive Analog and Digital Supply-Voltage Input
11	9	10	8	11	9	A	Digital Address “A” Input
10	8	9	7	10	8	B	Digital Address “B” Input
9	7	—	—	9	7	C	Digital Address “C” Input
8	6	8	6	8	6	GND	Ground. Connect to digital ground. (Analog signals have no ground reference; they are limited to V _{CC} and V _{EE} .)
7	5	7	5	7	5	V _{EE}	Negative Analog Supply-Voltage Input. Connect to GND for single-supply operation.
6	4	6	4	6	4	Enable	Digital Enable Input. Normally connected to GND.

Note: Input and output pins are identical and interchangeable. Any may be considered an input or output; signals pass equally well in both directions.

Applications Information

Power-Supply Considerations

Overview

The MAX4581/MAX4582/MAX4583 construction is typical of most CMOS analog switches. They have three

supply pins: V_{CC}, V_{EE}, and GND. V_{CC} and V_{EE} are used to drive the internal CMOS switches and set the limits of the analog voltage on any switch. Reverse ESD-protection diodes are internally connected between each analog-signal pin and both V_{CC} and V_{EE}. If any analog signal exceeds V_{CC} or V_{EE}, one of these diodes

Low-Voltage, CMOS Analog Multiplexers/Switches

MAX4581/MAX4582/MAX4583

Table 1. Truth Table/Switch Programming

ENABLE INPUT	SELECT INPUTS			ON SWITCHES		
	C*	B	A	MAX4581	MAX4582	MAX4583
H	X	X	X	All switches open	All switches open	All switches open
L	L	L	L	X-X0	X-X0, Y-Y0	X-X0, Y-Y0, Z-Z0
L	L	L	H	X-X1	X-X1, Y-Y1	X-X1, Y-Y0, Z-Z0
L	L	H	L	X-X2	X-X2, Y-Y2	X-X0, Y-Y1, Z-Z0
L	L	H	H	X-X3	X-X3, Y-Y3	X-X1, Y-Y1, Z-Z0
L	H	L	L	X-X4	X-X0, Y-Y0	X-X0, Y-Y0, Z-Z1
L	H	L	H	X-X5	X-X1, Y-Y1	X-X1, Y-Y0, Z-Z1
L	H	H	L	X-X6	X-X2, Y-Y2	X-X0, Y-Y1, Z-Z1
L	H	H	H	X-X7	X-X3, Y-Y3	X-X1, Y-Y1, Z-Z1

X = Don't care

*C not present on MAX4582.

Note: Input and output pins are identical and interchangeable. Either may be considered an input or output; signals pass equally well in either direction.

will conduct. During normal operation, these and other reverse-biased ESD diodes leak, forming the only current drawn from VCC or VEE.

Virtually all the analog leakage current comes from the ESD diodes. Although the ESD diodes on a given signal pin are identical and therefore fairly well balanced, they are reverse biased differently. Each is biased by either VCC or VEE and the analog signal. This means their leakages will vary as the signal varies. The *difference* in the two diode leakages to the VCC and VEE pins constitutes the analog-signal-path leakage current. All analog leakage current flows between each pin and one of the supply terminals, not to the other switch terminal. This is why both sides of a given switch can

show leakage currents of either the same or opposite polarity.

There is no connection between the analog-signal paths and GND.

VCC and GND power the internal logic and logic-level translators, and set the input logic limits. The logic-level translators convert the logic levels into switched VCC and VEE signals to drive the gates of the analog signals. This drive signal is the only connection between the logic supplies and signals and the analog supplies. VCC and VEE have ESD-protection diodes to GND.

The logic-level thresholds are TTL/CMOS compatible when VCC is +5V. As VCC rises, the threshold increases

Low-Voltage, CMOS Analog Multiplexers/Switches

slightly, so when V_{CC} reaches +12V the threshold is about 3.1V (above the TTL-guaranteed high-level minimum of 2.8V, but still compatible with CMOS outputs).

Bipolar Supplies

These devices operate with bipolar supplies between $\pm 2V$ and $\pm 5V$. The V_{CC} and V_{EE} supplies need not be symmetrical, but their sum cannot exceed the +13V absolute maximum rating

Single Supply

These devices operate from a single supply between +2V and +12V when V_{EE} is connected to GND. All of the bipolar precautions must be observed. At room temperature, they actually “work” with a single supply near or below +1.7V, although as supply voltage decreases, switch on-resistance and switching times become very high.

Overvoltage Protection

Proper power-supply sequencing is recommended for all CMOS devices. Do not exceed the absolute maximum ratings because stresses beyond the listed ratings can cause permanent damage to the devices. Always sequence V_{CC} on first, then V_{EE} , followed by the logic inputs and analog signals. If power-supply sequencing is not possible, add two small signal diodes (D1, D2) in series with the supply pins for overvoltage protection (Figure 1).

Adding diodes reduces the analog-signal range to one diode drop below V_{CC} and one diode drop above V_{EE} , but does not affect the devices' low switch resistance and low leakage characteristics. Device operation is unchanged, and the difference between V_{CC} and V_{EE} should not exceed 13V. These protection diodes are not recommended when using a single supply if signal levels must extend to ground.

High-Frequency Performance

In 50Ω systems, signal response is reasonably flat up to 50MHz (see *Typical Operating Characteristics*). Above 20MHz, the on response has several minor

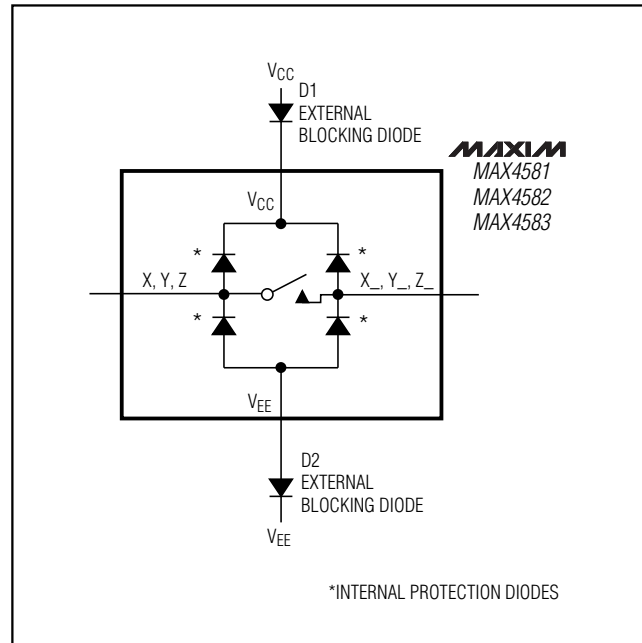


Figure 1. Overvoltage Protection Using External Blocking Diodes

peaks which are highly layout dependent. The problem is not turning the switch on, but turning it off. The off-state switch acts like a capacitor and passes higher frequencies with less attenuation. At 10MHz, off isolation is about -50dB in 50Ω systems, becoming worse (approximately 20dB per decade) as frequency increases. Higher circuit impedances also degrade off isolation. Adjacent channel attenuation is about 3dB above that of a bare IC socket and is entirely due to capacitive coupling.

Pin Nomenclature

The MAX4581/MAX4582/MAX4583 are pin-compatible with the industry-standard 74HC4051/74HC4052/74HC4053 and the MAX4051/MAX4052/MAX4053.

Low-Voltage, CMOS Analog Multiplexers/Switches

Test Circuits/Timing Diagrams

MAX4581/MAX4582/MAX4583

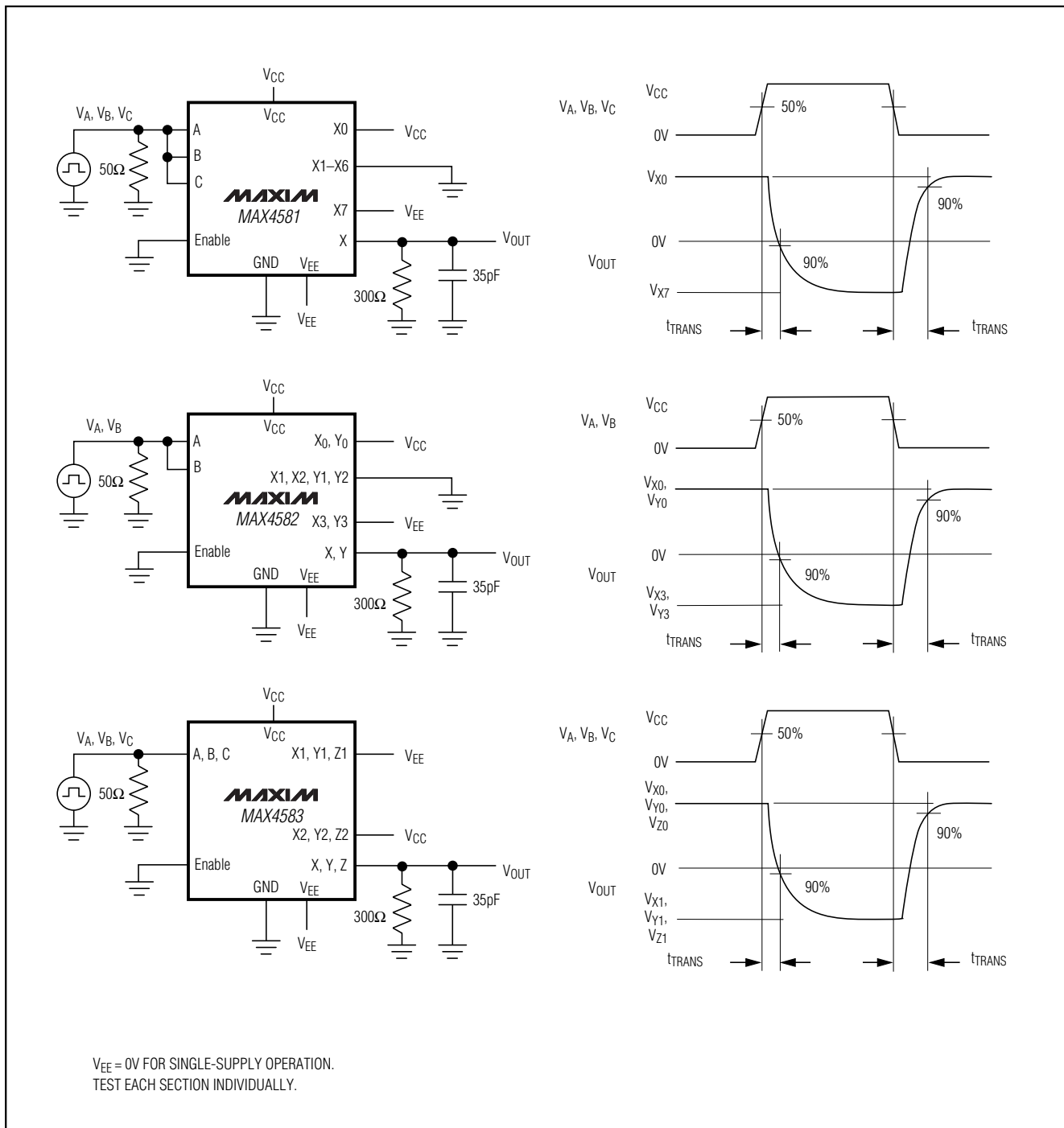
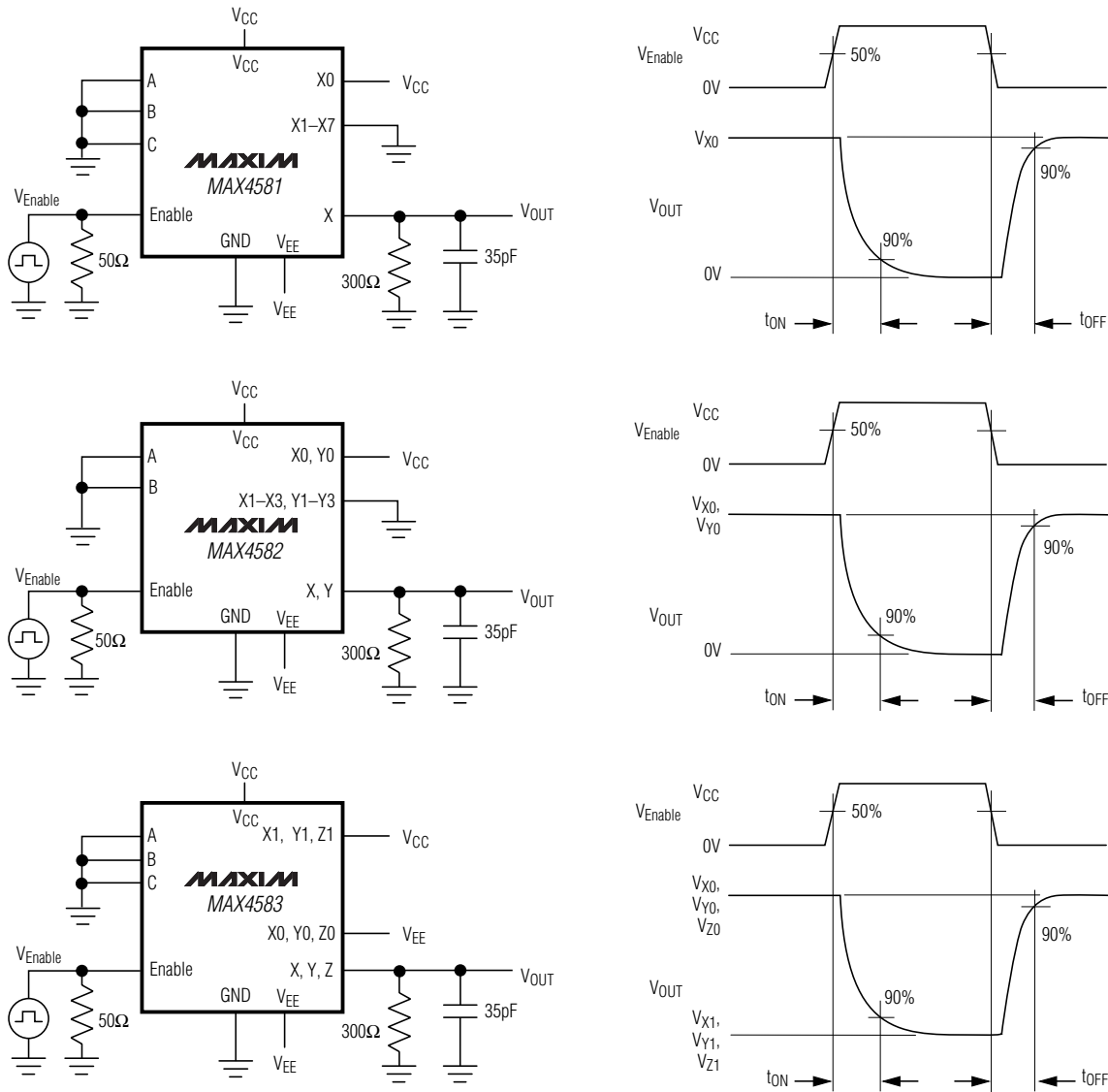


Figure 2. Address Transition Times

Low-Voltage, CMOS Analog Multiplexers/Switches

Test Circuits/Timing Diagrams (continued)



V_{EE} = 0V FOR SINGLE-SUPPLY OPERATION.
TEST EACH SECTION INDIVIDUALLY.

Figure 3. Inhibit Switching Times

Low-Voltage, CMOS Analog Multiplexers/Switches

Test Circuits/Timing Diagrams (continued)

MAX4581/MAX4582/MAX4583

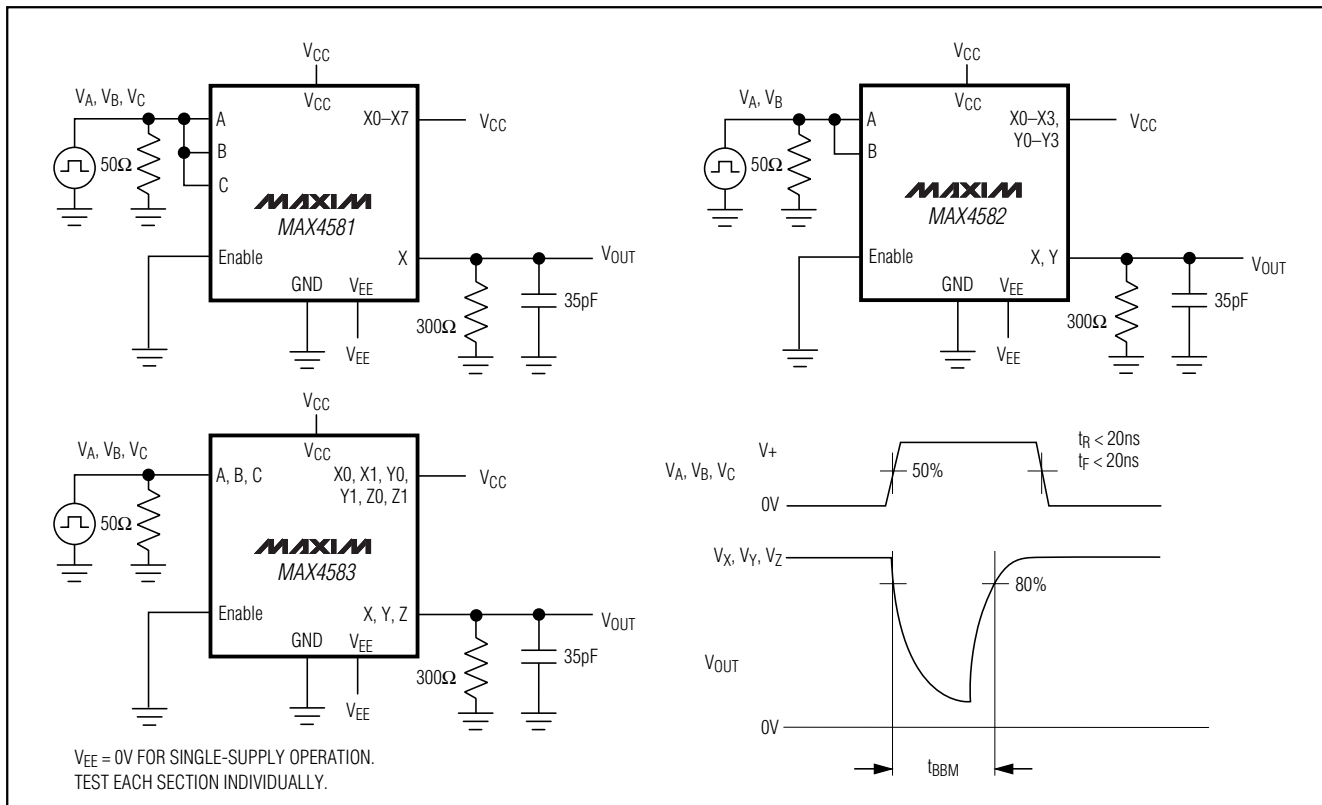


Figure 4. Break-Before-Make Interval

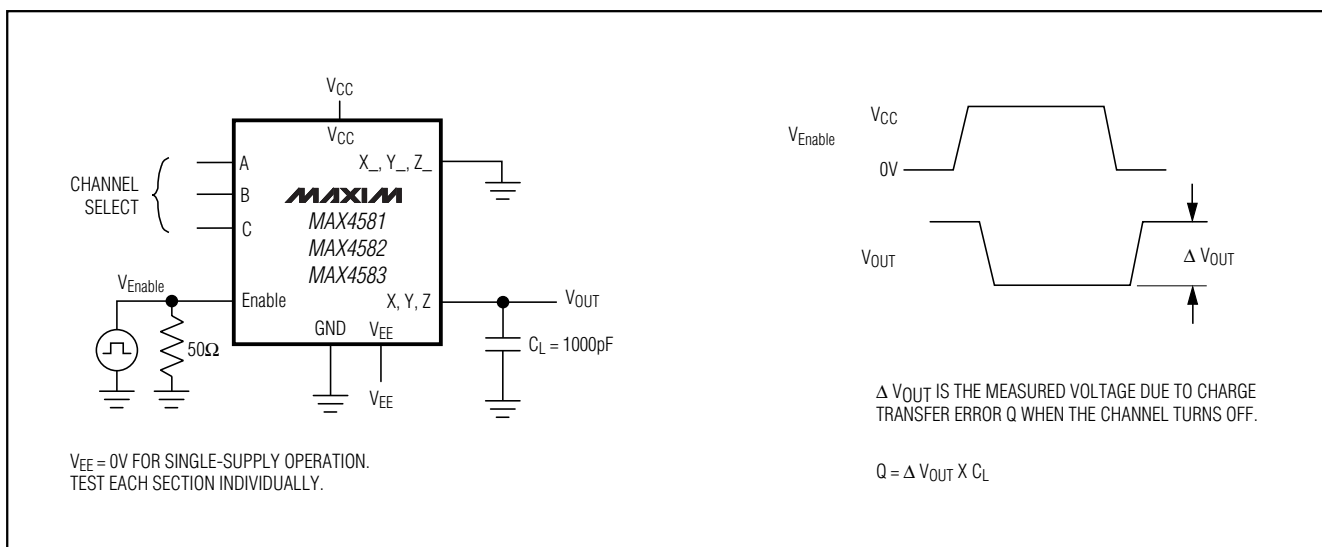


Figure 5. Charge Injection

Low-Voltage, CMOS Analog Multiplexers/Switches

Test Circuits/Timing Diagrams (continued)

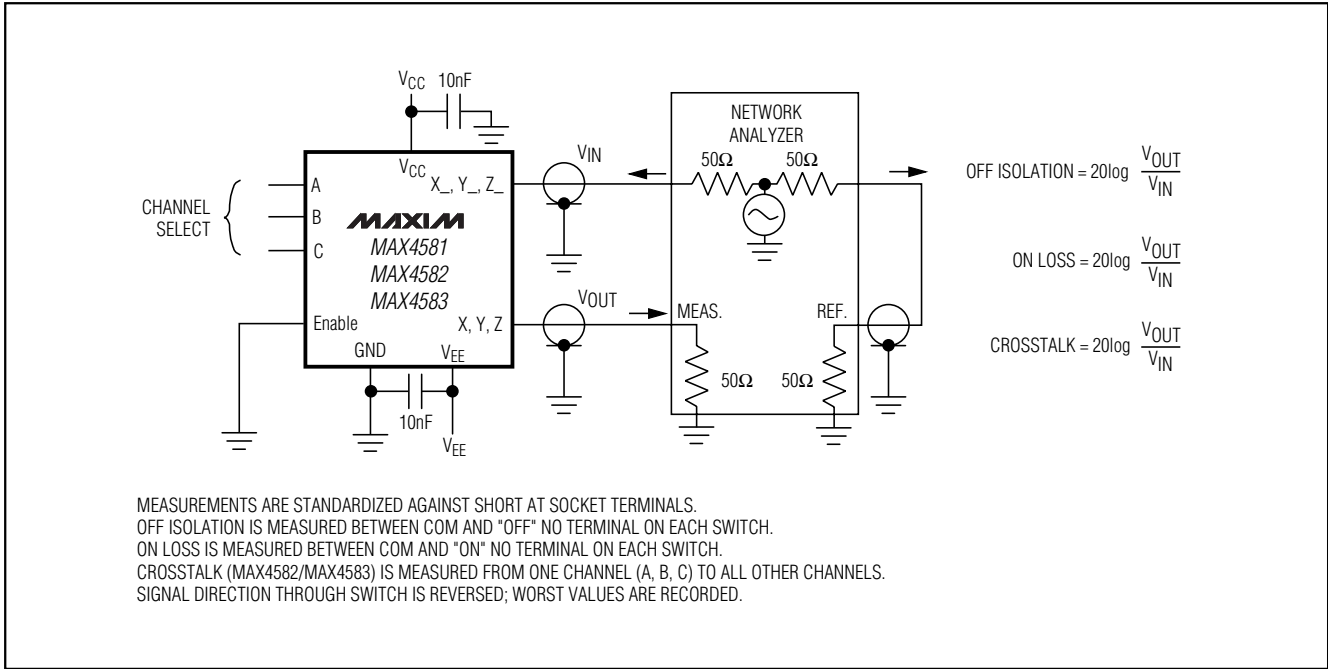


Figure 6. Off Isolation, On Loss, and Crosstalk

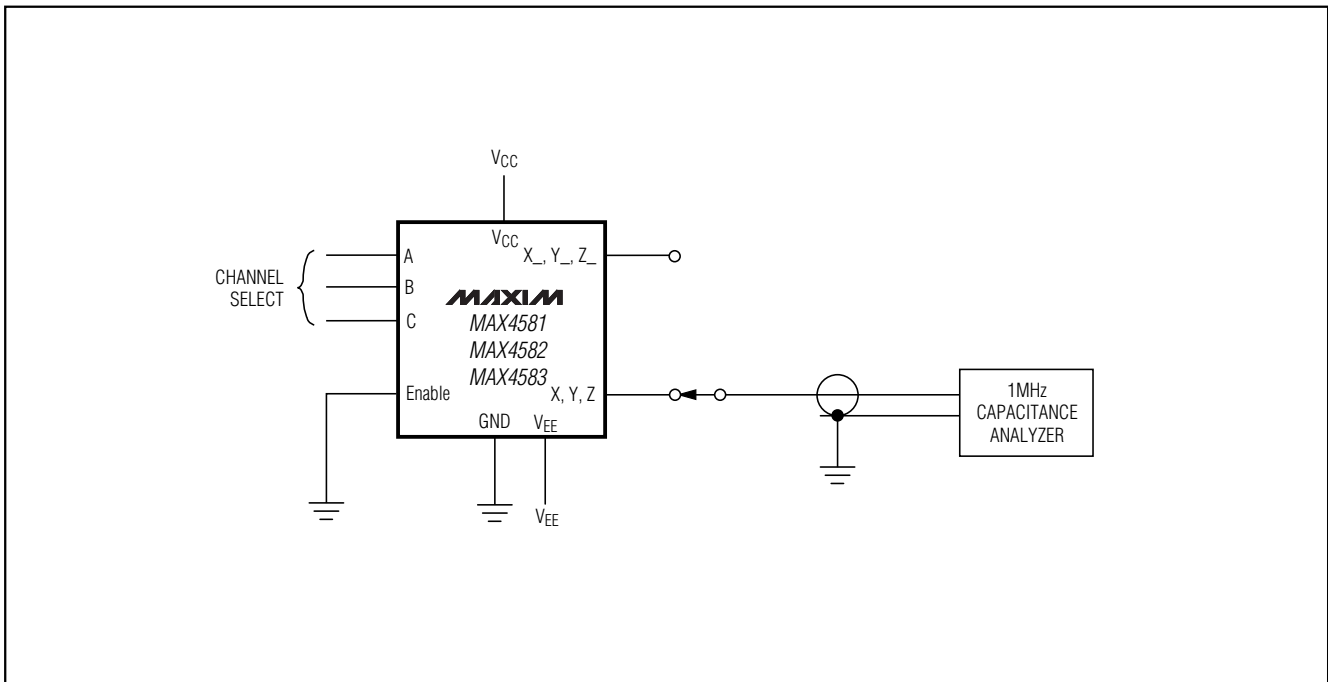


Figure 7. Capacitance

Low-Voltage, CMOS Analog Multiplexers/Switches

Ordering Information (continued)

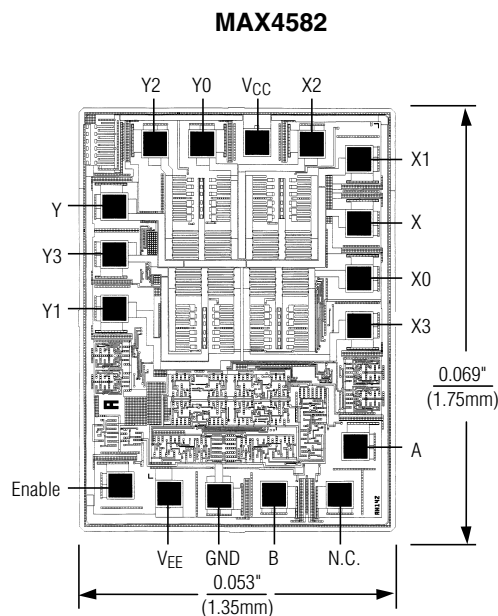
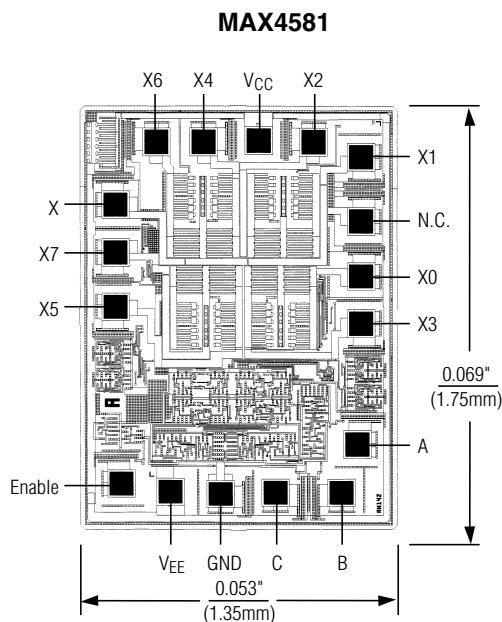
PART	TEMP. RANGE	PIN-PACKAGE
MAX4581CEE	0°C to +70°C	16 QSOP
MAX4581C/D	0°C to +70°C	Dice*
MAX4581EPE	-40°C to +85°C	16 Plastic DIP
MAX4581ESE	-40°C to +85°C	16 Narrow SO
MAX4581EUE	-40°C to +85°C	16 TSSOP
MAX4581EEE	-40°C to +85°C	16 QSOP
MAX4581EGE	-40°C to +85°C	16 QFN
MAX4581ASE	-40°C to +125°C	16 Narrow SO
MAX4581AUE	-40°C to +125°C	16 TSSOP
MAX4582CPE	0°C to +70°C	16 Plastic DIP
MAX4582CSE	0°C to +70°C	16 Narrow SO
MAX4582CUE	0°C to +70°C	16 TSSOP
MAX4582CEE	0°C to +70°C	16 QSOP
MAX4582C/D	0°C to +70°C	Dice*
MAX4582EPE	-40°C to +85°C	16 Plastic DIP
MAX4582ESE	-40°C to +85°C	16 Narrow SO

*Contact factory for availability.

PART	TEMP. RANGE	PIN-PACKAGE
MAX4582EUE	-40°C to +85°C	16 TSSOP
MAX4582EEE	-40°C to +85°C	16 QSOP
MAX4582EGE	-40°C to +85°C	16 QFN
MAX4582ASE	-40°C to +125°C	16 Narrow SO
MAX4582AUE	-40°C to +125°C	16 TSSOP
MAX4583CPE	0°C to +70°C	16 Plastic DIP
MAX4583CSE	0°C to +70°C	16 Narrow SO
MAX4583CUE	0°C to +70°C	16 TSSOP
MAX4583CEE	0°C to +70°C	16 QSOP
MAX4583C/D	0°C to +70°C	Dice*
MAX4583EPE	-40°C to +85°C	16 Plastic DIP
MAX4583ESE	-40°C to +85°C	16 Narrow SO
MAX4583EUE	-40°C to +85°C	16 TSSOP
MAX4583EEE	-40°C to +85°C	16 QSOP
MAX4583EGE	-40°C to +85°C	16 QFN
MAX4583ASE	-40°C to +125°C	16 Narrow SO
MAX4583AUE	-40°C to +125°C	16 TSSOP

MAX4581/MAX4582/MAX4583

Chip Topographies



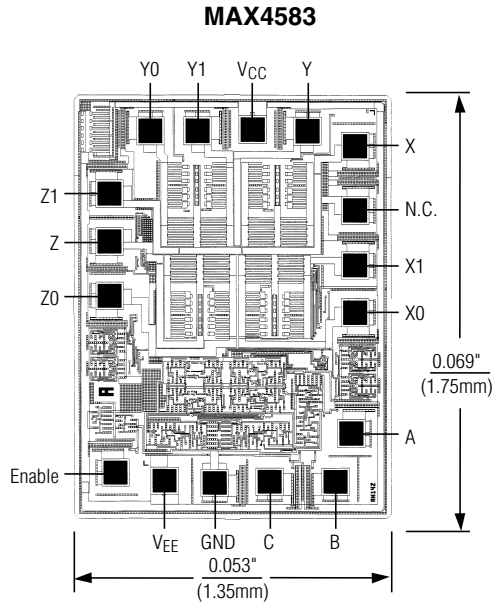
N.C. = NO CONNECTION

TRANSISTOR COUNT: 219
SUBSTRATE CONNECTED TO V+.

TRANSISTOR COUNT: 219
SUBSTRATE CONNECTED TO V+.

Low-Voltage, CMOS Analog Multiplexers/Switches

Chip Topographies (continued)



N.C. = NO CONNECTION

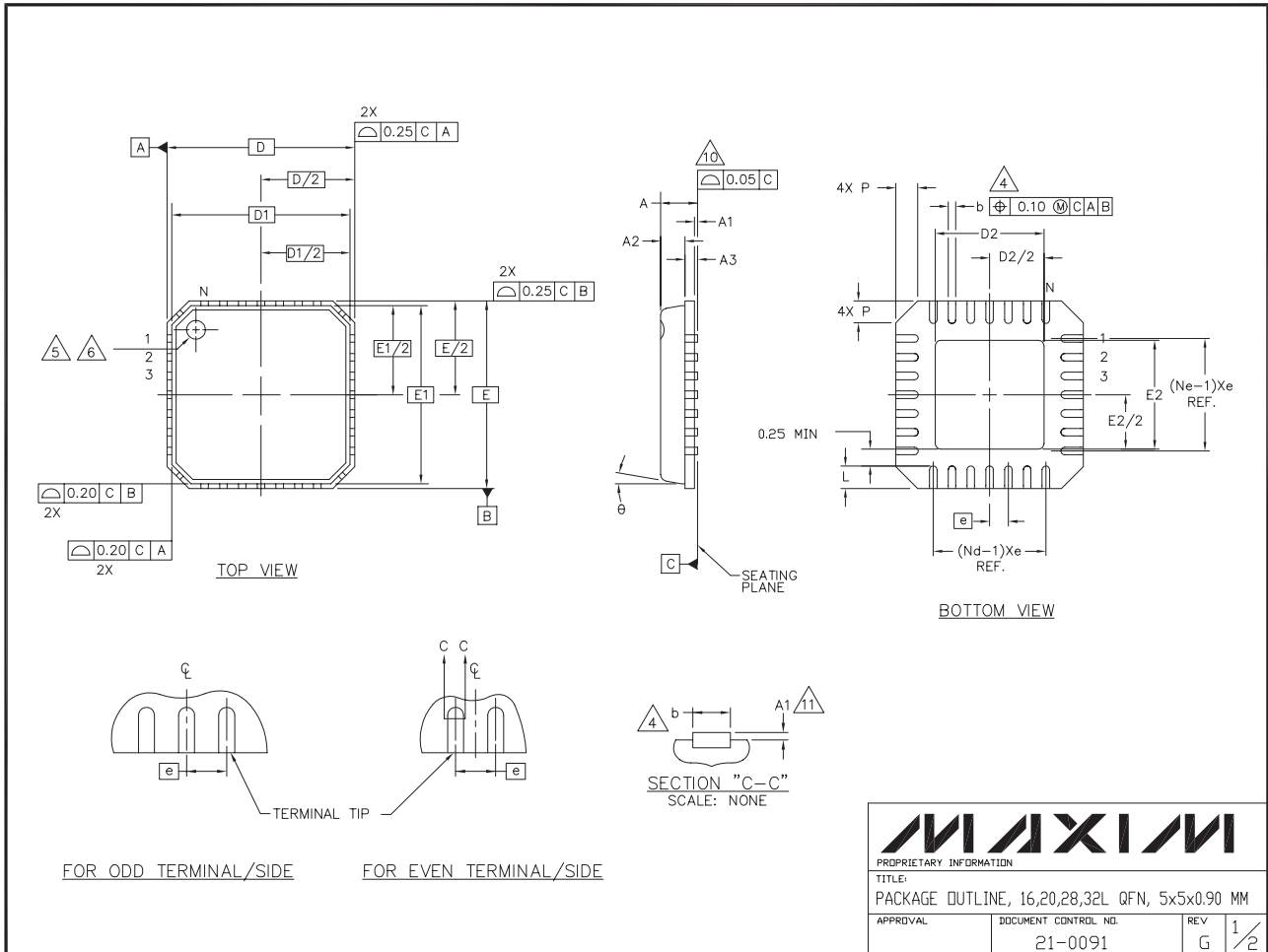
TRANSISTOR COUNT: 219

SUBSTRATE CONNECTED TO V+.

Low-Voltage, CMOS Analog Multiplexers/Switches

Package Information

MAX4581/MAX4582/MAX4583



Low-Voltage, CMOS Analog Multiplexers/Switches

Package Information (continued)

NOTES:

1. DIE THICKNESS ALLOWABLE IS 0.305mm MAXIMUM (.012 INCHES MAXIMUM)
2. DIMENSIONING & TOLERANCES CONFORM TO ASME Y14.5M. - 1994.
3. N IS THE NUMBER OF TERMINALS.
Nd IS THE NUMBER OF TERMINALS IN X-DIRECTION &
Ne IS THE NUMBER OF TERMINALS IN Y-DIRECTION.
4. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.20 AND 0.25mm FROM TERMINAL TIP.
5. THE PIN #1 IDENTIFIER MUST BE EXISTED ON THE TOP SURFACE OF THE PACKAGE BY USING INDENTATION MARK OR INK/ LASER MARKED.
6. EXACT SHAPE AND SIZE OF THIS FEATURE IS OPTIONAL.
7. ALL DIMENSIONS ARE IN MILLIMETERS.
8. PACKAGE WARPAGE MAX 0.05mm.
9. APPLIED FOR EXPOSED PAD AND TERMINALS.
EXCLUDE EMBEDDED PART OF EXPOSED PAD FROM MEASURING.
10. MEETS JEDEC MO220.
11. THIS PACKAGE OUTLINE APPLIES TO ANVIL SINGULATION (STEPPED SIDES) AND TO SAW SINGULATION (STRAIGHT SIDES) QFN STYLES.

S V B O L	COMMON DIMENSIONS			N O T E
	MIN.	NOM.	MAX.	
A	0.80	0.90	1.00	
A1	0.00	0.01	0.05	
A2	0.00	0.65	1.00	
A3	0.20 REF.			
D	5.00 BSC			
D1	4.75 BSC			
E	5.00 BSC			
E1	4.75 BSC			
θ	0°	-	12°	
P	0	-	0.60	
D2	1.25	-	3.25	
E2	1.25	-	3.25	

S V B O L	PITCH VARIATION B			N O T E	S V B O L	PITCH VARIATION B			N O T E	S V B O L	PITCH VARIATION C			N O T E	S V B O L	PITCH VARIATION D			N O T E
	MIN.	NOM.	MAX.			MIN.	NOM.	MAX.			MIN.	NOM.	MAX.			MIN.	NOM.	MAX.	
ⓐ	0.80 BSC				ⓐ	0.65 BSC				ⓐ	0.50 BSC				ⓐ	0.50 BSC			
N	16			3	N	20			3	N	28			3	N	32			3
Nd	4			3	Nd	5			3	Nd	7			3	Nd	8			3
Ne	4			3	Ne	5			3	Ne	7			3	Ne	8			3
L	0.35	0.55	0.75		L	0.35	0.55	0.75		L	0.35	0.55	0.75		L	0.30	0.40	0.50	
b	0.28	0.33	0.40	4	b	0.23	0.28	0.35	4	b	0.18	0.23	0.30	4	b	0.18	0.23	0.30	4

PROPRIETARY INFORMATION		
TITLE: PACKAGE OUTLINE, 16,20,28,32L QFN, 5x5x0.90 MM		
APPROVAL	DOCUMENT CONTROL NO. 21-0091	REV G 2/2

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